



EMI TEST REPORT

Test Report No. : 33CE0333-HO-B

Applicant : SHARP CORPORATION
Type of Equipment : Cellular Phone
Model No. : SH-05E
FCC ID : APYHRO00186
Test standard : FCC Part 15 Subpart B: 2012 Class B
Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test:

December 3 and 13, 2012

Representative test engineer:

Hironobu Ohnishi
Engineer of WiSE Japan,
UL Verification Service

Approved by:

Masanori Nishiyama
Manager of WiSE Japan,
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

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Head Office EMC Lab.

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13-EM-F0429

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SECTION 1: Customer information

Company Name : SHARP CORPORATION
Address : 2-13-1 Iida, Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,
739-0192 Japan
Telephone Number : +81-82-420-1826
Facsimile Number : +81-82-420-1829
Contact Person : Kazuo Sugimoto

SECTION 2: Equipment Under Test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Cellular Phone
Model No. : SH-05E
Serial No. : Refer to Section 4, Clause 4.2
Receipt Date of Sample : November 30, 2012
Country of Mass-production : Japan
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product description

Feature of EUT : LTE (FDD1) and Tetra-band WCDMA (FDD I / V / VI / XIX) and
Tetra-band GSM (850 / 900 / 1800 / 1900)
Cellular Phone / Bluetooth / W-LAN, Felica & 1.5GHz Band
Satellite Receiver (GPS) enable
- GSM (EU: 900 / 1800M, 1900M, US: 850M)
- WCDMA (EU: 2000M, US: 850M, JPN: 800 / 2000)
Clock frequency(ies) in the system : CPU: 1.512GHz
Source oscillation: 19.2MHz

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test Specification : FCC Part 15 Subpart B: 2012, final revised on August 13, 2012 and effective September 12, 2012

Title : FCC 47CFR Part15 Radio Frequency Device
Subpart B Unintentional Radiators

3.2 Procedures and results

| Item | Test Procedure | Limits | Deviation | Worst margin | Result |
|--------------------|--|---------|-----------|---|----------|
| Conducted emission | FCC: ANSI C63.4: 2009 7. AC powerline conducted emission measurements | Class B | N/A | [QP] 8.8dB 0.16803MHz, L 0.15517MHz, N [AV] 9.9dB 0.16803MHz, L | Complied |
| Radiated emission | FCC: ANSI C63.4: 2009 8. Radiated emission measurements | Class B | N/A | 7.9dB 366.092MHz Vertical, QP | Complied |

*Note: UL Japan, Inc's EMI Work Procedure 13-EM-W0420.

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

| Test room (semi-anechoic chamber) | Conducted emission (+dB) |
|--------------------------------------|-----------------------------|
| | 150kHz-30MHz |
| No.1 | 3.5dB |
| No.2 | 3.6dB |
| No.3 | 3.6dB |
| No.4 | 3.6dB |

| Test room (semi-anechoic chamber) | Radiated emission | | | | | | |
|--------------------------------------|-------------------|------------------|-----------------|----------------|-----------------|-------------------|-------------------|
| | (3m*)(+dB) | | | | (1m*)(+dB) | | (0.5m*)(+dB) |
| | 9kHz -30MHz | 30MHz -300MHz | 300MHz -1GHz | 1GHz -10GHz | 10GHz -18GHz | 18GHz -26.5GHz | 26.5GHz -40GHz |
| No.1 | 4.3dB | 5.0dB | 5.1dB | 4.9dB | 5.8dB | 4.4dB | 4.3dB |
| No.2 | 4.3dB | 5.2dB | 5.1dB | 5.0dB | 5.7dB | 4.3dB | 4.2dB |
| No.3 | 4.6dB | 5.0dB | 5.1dB | 5.0dB | 5.7dB | 4.5dB | 4.2dB |
| No.4 | 4.8dB | 5.2dB | 5.0dB | 5.0dB | 5.7dB | 5.2dB | 4.2dB |

*3m/1m/0.5m = Measurement distance

Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

UL Japan, Inc. Head Office EMC Lab. *NVLAP Lab. code: 200572-0
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Telephone: +81 596 24 8116 Facsimile: +81 596 24 8124

| | FCC Registration Number | IC Registration Number | Width x Depth x Height (m) | Size of reference ground plane (m) / horizontal conducting plane | Other rooms |
|----------------------------|-------------------------|------------------------|----------------------------|--|------------------------|
| No.1 semi-anechoic chamber | 313583 | 2973C-1 | 19.2 x 11.2 x 7.7m | 7.0 x 6.0m | No.1 Power source room |
| No.2 semi-anechoic chamber | 655103 | 2973C-2 | 7.5 x 5.8 x 5.2m | 4.0 x 4.0m | - |
| No.3 semi-anechoic chamber | 148738 | 2973C-3 | 12.0 x 8.5 x 5.9m | 6.8 x 5.75m | No.3 Preparation room |
| No.3 shielded room | - | - | 4.0 x 6.0 x 2.7m | N/A | - |
| No.4 semi-anechoic chamber | 134570 | 2973C-4 | 12.0 x 8.5 x 5.9m | 6.8 x 5.75m | No.4 Preparation room |
| No.4 shielded room | - | - | 4.0 x 6.0 x 2.7m | N/A | - |
| No.5 semi-anechoic chamber | - | - | 6.0 x 6.0 x 3.9m | 6.0 x 6.0m | - |
| No.6 shielded room | - | - | 4.0 x 4.5 x 2.7m | 4.75 x 5.4 m | - |
| No.6 measurement room | - | - | 4.75 x 5.4 x 3.0m | 4.75 x 4.15 m | - |
| No.7 shielded room | - | - | 4.7 x 7.5 x 2.7m | 4.7 x 7.5m | - |
| No.8 measurement room | - | - | 3.1 x 5.0 x 2.7m | N/A | - |
| No.9 measurement room | - | - | 8.0 x 4.5 x 2.8m | 2.0 x 2.0m | - |
| No.10 measurement room | - | - | 2.6 x 2.8 x 2.5m | 2.4 x 2.4m | - |
| No.11 measurement room | - | - | 3.1 x 3.4 x 3.0m | 2.4 x 3.4m | - |

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX.

Description of EUT and Support equipment

| No. | Item | Model number | Serial number | Manufacturer | Remarks |
|-----|---------------------|-------------------|--------------------------|-------------------|---------|
| A | Cellular Phone | SH-05E | 004401114675362 | SHARP CORPORATION | EUT |
| B | Lithium-Ion Battery | Battery Pack SH36 | - | SHARP CORPORATION | EUT |
| C | Personal Computer | PP11L | CN-0D4571-48643-58P-1053 | DELL | - |
| D | Mouse | M-UAG120 | G83C0007F310 | TOSHIBA | - |
| E | AC Adapter (PC) | PA-1650-05D2 | CN-0F7970-71615-77H-0D63 | DELL | - |
| F | Printer | C6410A | 8G8BA1W18J | Hewlett Packard | - |
| G | AC Adapter(Printer) | AT-3018A-0101 | C4557-60004 | Hewlett Packard | - |

List of cables used

| No. | Name | Length (m) | Shield | | Remarks |
|-----|-------------------------|------------|------------|------------|---------|
| | | | Cable | Connector | |
| 1 | USB Data Cable | 1.15 | Shielded | Shielded | - |
| 2 | Mouse Cable | 0.71 | Shielded | Shielded | - |
| 3 | Printer Cable | 2.00 | Shielded | Shielded | - |
| 4 | DC Power Cable(Printer) | 2.00 | Unshielded | Unshielded | - |
| 5 | AC Power Cable(Printer) | 1.80 | Unshielded | Unshielded | - |
| 6 | DC Power Cable(PC) | 1.80 | Unshielded | Unshielded | - |
| 7 | AC Power Cable(PC) | 0.90 | Unshielded | Unshielded | - |

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SECTION 5: Conducted Emission

5.1 Operating environment

Test place : No. 1 semi anechoic chamber.
Temperature : See data
Humidity : See data

5.2 Test configuration

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT and its peripherals was aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from the LISN/AMN and excess AC cable was bundled in center. I/O cables that were connected to the other peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN/AMN to the input power source. All unused 50 ohm connectors of the LISN/AMN were resistivity terminated in 50 ohm when not connected to the measuring equipment. Photographs of the set up are shown in Appendix 3.

Frequency range : 0.15 MHz-30MHz
EUT position : Table top
EUT operation mode : See Clause 4.1

5.3 Test procedure

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT within a semi anechoic chamber. The EUT was connected to a Line Impedance Stabilization Network (LISN)/ Artificial Mains network (AMN). An overview sweep with peak detection has been performed. The measurements have been performed with a quasi-peak detector and if required, with an average detector.

The conducted emission measurements were made with the following detector function of the test receiver.

Detector Type : Quasi-Peak and Average
IF Bandwidth : 9 kHz

5.4 Test result

Summary of the test results: Pass

Date: December 3, 2012

Test engineer: Hiroshi Kukita

UL Japan, Inc.

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SECTION 6: Radiated Emission

6.1 Operating environment

Test place : No. 1 semi anechoic chamber
Temperature : See data
Humidity : See data

6.2 Test configuration

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The EUT was set on the edge of the tabletop.
Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.
Photographs of the set up are shown in Appendix 3.

6.3 Test conditions

Frequency range : 30MHz-300MHz (Biconical antenna) / 300MHz-1000MHz (Logperiodic antenna)
1000MHz-10000MHz (Horn antenna)
Test distance : 3m
EUT position : Table top
EUT operation mode : See Clause 4.1

6.4 Test procedure

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.
The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.
The radiated emission measurements were made with the following detector function of the test receiver and the Spectrum analyzer.

| | | |
|-----------------|---------------|---|
| Frequency | Below 1GHz | Above 1GHz |
| Instrument used | Test Receiver | Spectrum Analyzer |
| IF Bandwidth | QP: BW 120kHz | PK: RBW:1MHz/VBW: 3MHz AV *1): RBW:1MHz/VBW:10Hz |

*1) When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

- The noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

6.5 Test result

Summary of the test results: Pass

Date: December 13, 2012

Test engineer: Hironobu Ohnishi

UL Japan, Inc.

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APPENDIX 1: Data of EMI test

Conducted Emission

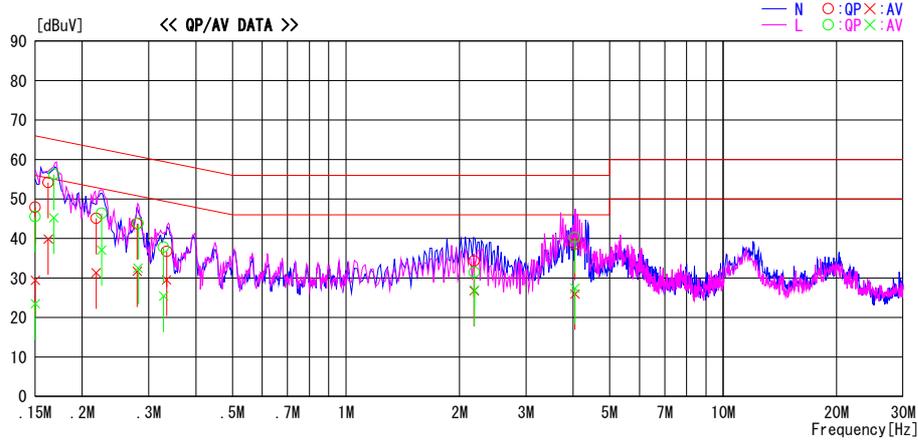
DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber
Date : 2012/12/03

Report No. : 33CE0333-HO...
Temp./Humi. : 18deg. C / 41% RH
Engineer : Hiroshi Kukita

Mode / Remarks : USB Data Com Mode

LIMIT : FCC15.107(a) QP ClassB
FCC15.107(a) AV ClassB



| Frequency [MHz] | Reading Level | | Corr. Factor [dB] | Results | | Limit | | Margin | | Phase | Comment |
|--------------------|---------------|--------------|-------------------------|--------------|--------------|--------------|--------------|------------|------------|-------|---------|
| | QP [dBuV] | AV [dBuV] | | QP [dBuV] | AV [dBuV] | QP [dBuV] | AV [dBuV] | QP [dB] | AV [dB] | | |
| 0.15000 | 34.7 | 16.2 | 13.2 | 47.9 | 29.4 | 66.0 | 56.0 | 18.1 | 26.6 | N | |
| 0.16249 | 41.0 | 26.7 | 13.2 | 54.2 | 39.9 | 65.3 | 55.3 | 11.1 | 15.4 | N | |
| 0.21750 | 31.9 | 18.1 | 13.2 | 45.1 | 31.3 | 62.9 | 52.9 | 17.8 | 21.6 | N | |
| 0.27970 | 30.4 | 18.4 | 13.3 | 43.7 | 31.7 | 60.8 | 50.8 | 17.1 | 19.1 | N | |
| 0.33470 | 23.4 | 16.2 | 13.3 | 36.7 | 29.5 | 59.3 | 49.3 | 22.6 | 19.8 | N | |
| 2.18521 | 20.6 | 13.1 | 13.7 | 34.3 | 26.8 | 56.0 | 46.0 | 21.7 | 19.2 | N | |
| 4.04480 | 24.6 | 12.0 | 14.0 | 38.6 | 26.0 | 56.0 | 46.0 | 17.4 | 20.0 | N | |
| 0.15000 | 32.4 | 10.3 | 13.2 | 45.6 | 23.5 | 66.0 | 56.0 | 20.4 | 32.5 | L | |
| 0.16803 | 43.1 | 32.0 | 13.2 | 56.3 | 45.2 | 65.1 | 55.1 | 8.8 | 9.9 | L | |
| 0.22500 | 33.2 | 23.9 | 13.2 | 46.4 | 37.1 | 62.6 | 52.6 | 16.2 | 15.5 | L | |
| 0.28119 | 30.5 | 19.2 | 13.3 | 43.8 | 32.5 | 60.8 | 50.8 | 17.0 | 18.3 | L | |
| 0.32828 | 24.5 | 12.1 | 13.3 | 37.8 | 25.4 | 59.5 | 49.5 | 21.7 | 24.1 | L | |
| 2.19008 | 17.8 | 13.2 | 13.7 | 31.5 | 26.9 | 56.0 | 46.0 | 24.5 | 19.1 | L | |
| 4.04820 | 26.3 | 13.4 | 14.0 | 40.3 | 27.4 | 56.0 | 46.0 | 15.7 | 18.6 | L | |

CHART:WITH FACTOR,Peak hold data. CALCULATION:RESULT=READING+C.F(LISN LOSS + ATTEN LOSS + CABLE LOSS)
Except for the above table : adequate margin data below the limits.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

Conducted Emission

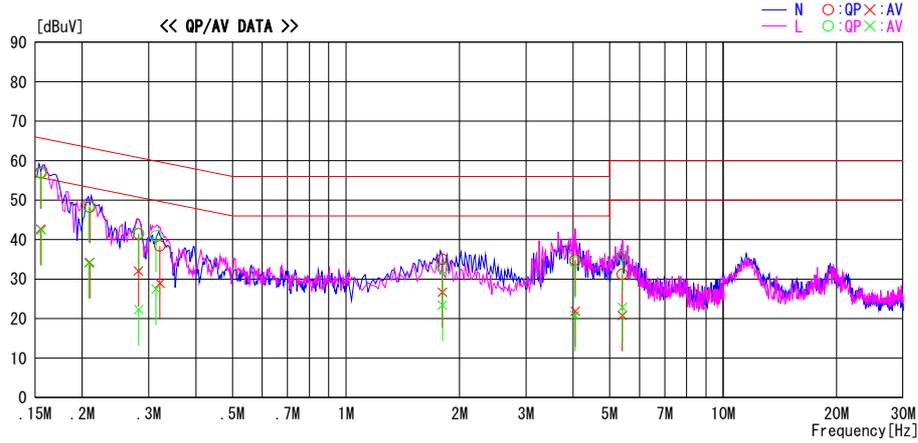
DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber
Date : 2012/12/03

Report No. : 33CE0333-H0
Temp./Humi. : 18deg. C / 41% RH
Engineer : Hiroshi Kukita

Mode / Remarks : Standby Mode

LIMIT : FCC15.107(a) QP ClassB
FCC15.107(a) AV ClassB



| Frequency [MHz] | Reading Level | | Corr. Factor [dB] | Results | | Limit | | Margin | | Phase | Comment |
|--------------------|---------------|--------------|-------------------------|--------------|--------------|--------------|--------------|------------|------------|-------|---------|
| | QP [dBuV] | AV [dBuV] | | QP [dBuV] | AV [dBuV] | QP [dBuV] | AV [dBuV] | QP [dB] | AV [dB] | | |
| 0.15517 | 43.7 | 29.5 | 13.2 | 56.9 | 42.7 | 65.7 | 55.7 | 8.8 | 13.0 | N | |
| 0.20906 | 35.0 | 21.0 | 13.2 | 48.2 | 34.2 | 63.2 | 53.2 | 15.0 | 19.0 | N | |
| 0.28180 | 28.2 | 18.8 | 13.3 | 41.5 | 32.1 | 60.8 | 50.8 | 19.3 | 18.7 | N | |
| 0.32130 | 25.1 | 15.7 | 13.3 | 38.4 | 29.0 | 59.7 | 49.7 | 21.3 | 20.7 | N | |
| 1.80034 | 21.4 | 13.1 | 13.6 | 35.0 | 26.7 | 56.0 | 46.0 | 21.0 | 19.3 | N | |
| 4.05340 | 20.8 | 7.9 | 14.0 | 34.8 | 21.9 | 56.0 | 46.0 | 21.2 | 24.1 | N | |
| 5.40500 | 17.0 | 6.6 | 14.2 | 31.2 | 20.8 | 60.0 | 50.0 | 28.8 | 29.2 | N | |
| 0.15570 | 43.6 | 29.2 | 13.2 | 56.8 | 42.4 | 65.7 | 55.7 | 8.9 | 13.3 | L | |
| 0.20810 | 35.2 | 20.9 | 13.2 | 48.4 | 34.1 | 63.3 | 53.3 | 14.9 | 19.2 | L | |
| 0.28200 | 28.3 | 9.0 | 13.3 | 41.6 | 22.3 | 60.8 | 50.8 | 19.2 | 28.5 | L | |
| 0.31360 | 27.6 | 14.2 | 13.3 | 40.9 | 27.5 | 59.9 | 49.9 | 19.0 | 22.4 | L | |
| 1.80250 | 19.2 | 9.8 | 13.6 | 32.8 | 23.4 | 56.0 | 46.0 | 23.2 | 22.6 | L | |
| 4.05080 | 20.3 | 6.8 | 14.0 | 34.3 | 20.8 | 56.0 | 46.0 | 21.7 | 25.2 | L | |
| 5.40700 | 21.7 | 8.7 | 14.2 | 35.9 | 22.9 | 60.0 | 50.0 | 24.1 | 27.1 | L | |

CHART: WITH FACTOR, Peak hold data. CALCULATION: RESULT=READING+C.F (LISN LOSS + ATTEN LOSS + CABLE LOSS)
Except for the above table : adequate margin data below the limits.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

Radiated Emission
(Below 1GHz)

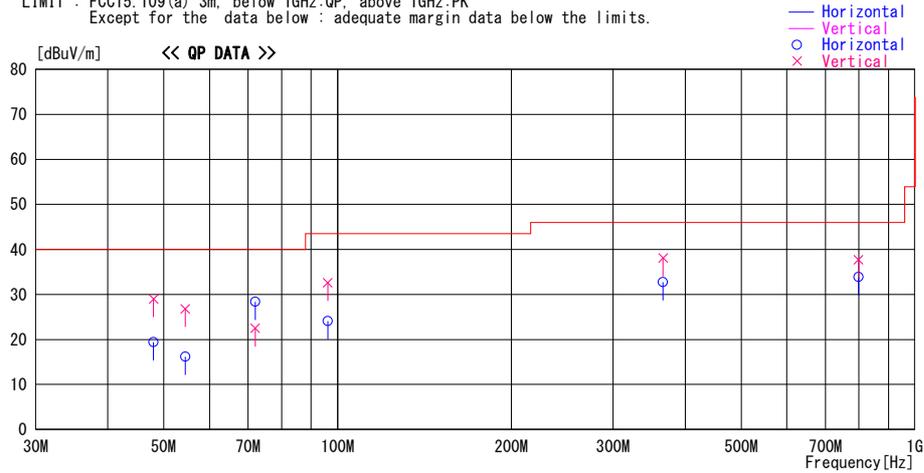
DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber
Date : 2012/12/13

Report No. : 33CE0333-HO
Temp./Humi. : 22deg. C / 35% RH
Engineer : Hironobu Ohnishi

Mode / Remarks : USB Data Com Mode, Worst axis (Hori: X, Vert: X)

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:PK
Except for the data below : adequate margin data below the limits.



| Frequency [MHz] | Reading [dBuV] | DET | Antenna | | Level [dBuV/m] | Angle [Deg] | Height [cm] | Polar. | Limit [dBuV/m] | Margin [dB] | Comment |
|--------------------|-------------------|-----|------------------|-----------------------|-------------------|----------------|----------------|--------|-------------------|----------------|---------|
| | | | Factor [dB/m] | Loss& Gain [dB] | | | | | | | |
| 48.013 | 38.8 | QP | 11.8 | -31.2 | 19.4 | 110 | 324 | Hori. | 40.0 | 20.6 | |
| 48.013 | 48.4 | QP | 11.8 | -31.2 | 29.0 | 91 | 100 | Vert. | 40.0 | 11.0 | |
| 54.496 | 37.5 | QP | 9.8 | -31.1 | 16.2 | 126 | 370 | Hori. | 40.0 | 23.8 | |
| 54.496 | 48.1 | QP | 9.8 | -31.1 | 26.8 | 162 | 100 | Vert. | 40.0 | 13.2 | |
| 72.019 | 52.5 | QP | 6.7 | -30.8 | 28.4 | 113 | 261 | Hori. | 40.0 | 11.6 | |
| 72.019 | 46.6 | QP | 6.7 | -30.8 | 22.5 | 54 | 179 | Vert. | 40.0 | 17.5 | |
| 96.134 | 45.0 | QP | 9.6 | -30.5 | 24.1 | 44 | 333 | Hori. | 43.5 | 19.4 | |
| 96.134 | 53.5 | QP | 9.6 | -30.5 | 32.6 | 156 | 100 | Vert. | 43.5 | 10.9 | |
| 366.092 | 43.7 | QP | 16.6 | -27.6 | 32.7 | 147 | 100 | Hori. | 46.0 | 13.3 | |
| 366.092 | 49.1 | QP | 16.6 | -27.6 | 38.1 | 185 | 159 | Vert. | 46.0 | 7.9 | |
| 798.293 | 35.8 | QP | 22.4 | -24.3 | 33.9 | 132 | 117 | Hori. | 46.0 | 12.1 | |
| 798.293 | 39.6 | QP | 22.4 | -24.3 | 37.7 | 68 | 100 | Vert. | 46.0 | 8.3 | |

CHART: WITH FACTOR ANT TYPE: -30MHz: LOOP, 30-300MHz: BICONICAL, 300MHz-1000MHz: LOGPERIODIC, 1000MHz-: HORN
CALCULATION: RESULT = READING + ANT FACTOR + LOSS (CABLE+ATTEN.) - GAIN (AMP)

*The limit is rounded down to one decimal place.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

Radiated Emission
(Below 1GHz)

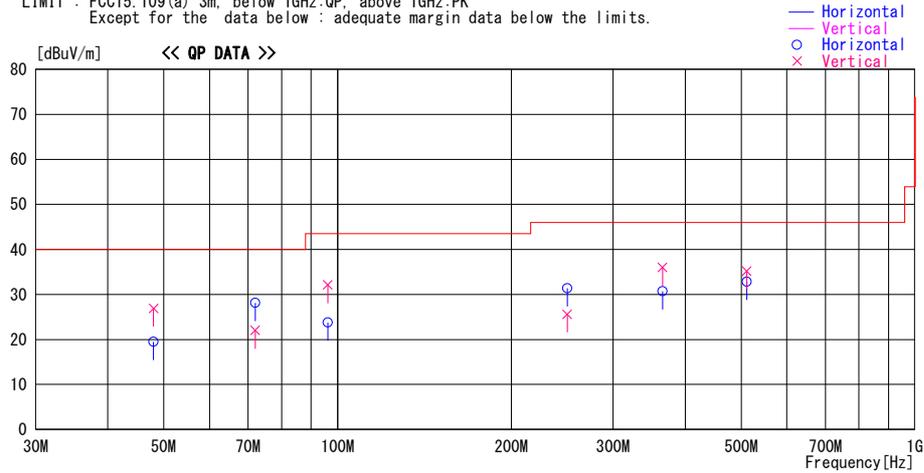
DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber
Date : 2012/12/13

Report No. : 33CE0333-HO
Temp./Humi. : 22deg. C / 35% RH
Engineer : Hironobu Ohnishi

Mode / Remarks : Standby Mode, Worst axis (Hori: X, Vert: X)

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:PK
Except for the data below : adequate margin data below the limits.



| Frequency [MHz] | Reading [dBuV] | DET | Antenna | | Level [dBuV/m] | Angle [Deg] | Height [cm] | Polar. | Limit [dBuV/m] | Margin [dB] | Comment |
|--------------------|-------------------|-----|------------------|-----------------------|-------------------|----------------|----------------|--------|-------------------|----------------|---------|
| | | | Factor [dB/m] | Loss& Gain [dB] | | | | | | | |
| 48.012 | 38.9 | QP | 11.8 | -31.2 | 19.5 | 108 | 332 | Hori. | 40.0 | 20.5 | |
| 48.012 | 46.3 | QP | 11.8 | -31.2 | 26.9 | 103 | 100 | Vert. | 40.0 | 13.1 | |
| 72.018 | 52.2 | QP | 6.7 | -30.8 | 28.1 | 110 | 264 | Hori. | 40.0 | 11.9 | |
| 72.018 | 46.1 | QP | 6.7 | -30.8 | 22.0 | 64 | 178 | Vert. | 40.0 | 18.0 | |
| 96.134 | 44.7 | QP | 9.6 | -30.5 | 23.8 | 51 | 339 | Hori. | 43.5 | 19.7 | |
| 96.134 | 53.0 | QP | 9.6 | -30.5 | 32.1 | 169 | 100 | Vert. | 43.5 | 11.4 | |
| 249.997 | 42.6 | QP | 17.5 | -28.7 | 31.4 | 260 | 129 | Hori. | 46.0 | 14.6 | |
| 249.997 | 36.8 | QP | 17.5 | -28.7 | 25.6 | 308 | 100 | Vert. | 46.0 | 20.4 | |
| 365.450 | 41.7 | QP | 16.6 | -27.6 | 30.7 | 151 | 100 | Hori. | 46.0 | 15.3 | |
| 365.450 | 47.0 | QP | 16.6 | -27.6 | 36.0 | 174 | 157 | Vert. | 46.0 | 10.0 | |
| 511.271 | 40.8 | QP | 18.3 | -26.3 | 32.8 | 124 | 100 | Hori. | 46.0 | 13.2 | |
| 511.271 | 43.2 | QP | 18.3 | -26.3 | 35.2 | 41 | 152 | Vert. | 46.0 | 10.8 | |

CHART: WITH FACTOR ANT TYPE: -30MHz: LOOP, 30-300MHz: BICONICAL, 300MHz-1000MHz: LOGPERIODIC, 1000MHz: HORN
CALCULATION: RESULT = READING + ANT FACTOR + LOSS (CABLE+ATTEN.) - GAIN (AMP)

*The limit is rounded down to one decimal place.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

Radiated Emission
(Above 1GHz)

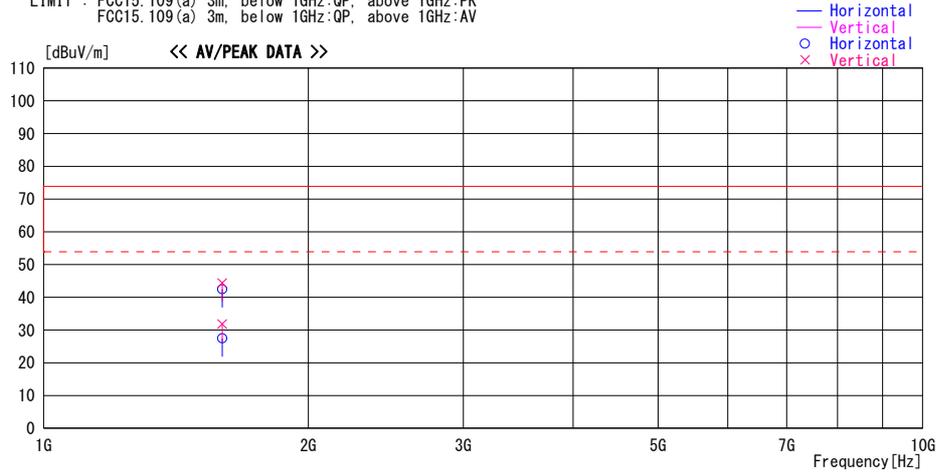
DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber
Date : 2012/12/13

Report No. : 33CE0333-HO
Temp./Humi. : 22deg. C / 35% RH
Engineer : Hironobu Ohnishi

Mode / Remarks : USB Data Com Mode, Worst axis (Hori: X, Vert: X)

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:PK
FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:AV



| Frequency [MHz] | Reading [dBuV] | DET | Antenna | Loss& | Level | Angle | Height | Polar. | Limit | | Comment |
|--------------------|-------------------|-----|---------|-------|----------|-------|--------|--------|----------|------|---------|
| | | | Factor | Gain | | | | | [dBuV/m] | [dB] | |
| | | | [dB/m] | [dB] | [dBuV/m] | [Deg] | [cm] | | [dBuV/m] | [dB] | |
| 1596.100 | 51.3 | PK | 25.8 | -34.6 | 42.5 | 115 | 100 | Hori. | 73.9 | 31.4 | |
| 1596.100 | 36.3 | AV | 25.8 | -34.6 | 27.5 | 115 | 100 | Hori. | 53.9 | 26.4 | |
| 1596.100 | 53.2 | PK | 25.8 | -34.6 | 44.4 | 66 | 100 | Vert. | 73.9 | 29.5 | |
| 1596.100 | 40.7 | AV | 25.8 | -34.6 | 31.9 | 66 | 100 | Vert. | 53.9 | 22.0 | |

CHART:WITH FACTOR ANT TYPE: -30MHz:LOOP, 30-300MHz:BICONICAL, 300MHz-1000MHz:LOGPERIODIC, 1000MHz:-HORN
CALCULATION:RESULT = READING + ANT FACTOR + LOSS(CABLE+ATTEN.) - GAIN(AMP)

*The limit is rounded down to one decimal place.
*The test result is rounded off to one or two decimal places, so some differences might be observed.

Radiated Emission
(Above 1GHz)

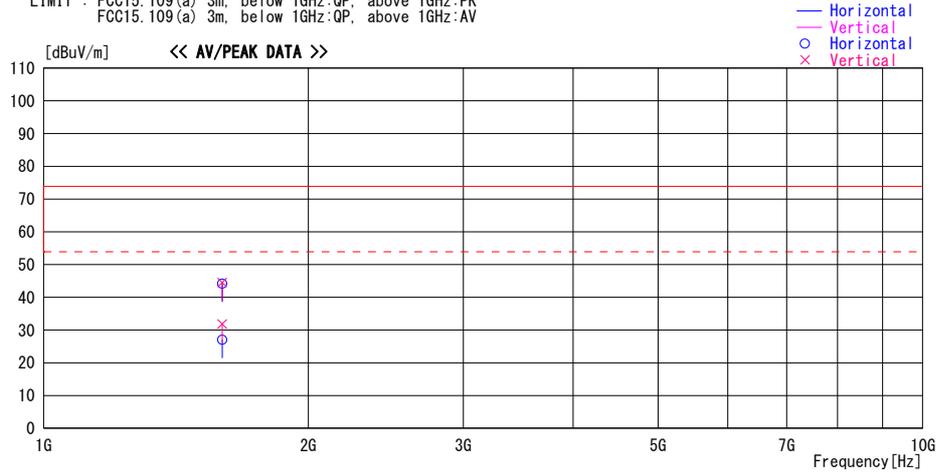
DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber
Date : 2012/12/13

Report No. : 33CE0333-HO
Temp./Humi. : 22deg. C / 35% RH
Engineer : Hironobu Ohnishi

Mode / Remarks : Standby Mode, Worst axis (Hori: X, Vert: X)

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:PK
FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:AV



| Frequency [MHz] | Reading [dBuV] | DET | Antenna | Loss& | Level [dBuV/m] | Angle [Deg] | Height [cm] | Polar. | Limit | Margin | Comment |
|--------------------|-------------------|-----|------------------|--------------|-------------------|----------------|----------------|--------|----------|--------|---------|
| | | | Factor [dB/m] | Gain [dB] | | | | | [dBuV/m] | [dB] | |
| 1596.100 | 52.9 | PK | 25.8 | -34.6 | 44.1 | 58 | 100 | Hori. | 73.9 | 29.8 | |
| 1596.100 | 35.8 | AV | 25.8 | -34.6 | 27.0 | 58 | 100 | Hori. | 53.9 | 26.9 | |
| 1596.100 | 53.3 | PK | 25.8 | -34.6 | 44.5 | 63 | 100 | Vert. | 73.9 | 29.4 | |
| 1596.100 | 40.7 | AV | 25.8 | -34.6 | 31.9 | 63 | 100 | Vert. | 53.9 | 22.0 | |

CHART:WITH FACTOR ANT TYPE: -30MHz:LOOP, 30-300MHz:BICONICAL, 300MHz-1000MHz:LOGPERIODIC, 1000MHz:-HORN
CALCULATION:RESULT = READING + ANT FACTOR + LOSS(CABLE+ATTEN.) - GAIN(AMP)

*The limit is rounded down to one decimal place.
*The test result is rounded off to one or two decimal places, so some differences might be observed.

APPENDIX 2: Test instruments

EMI Test Instruments

| Control No. | Instrument | Manufacturer | Model No | Serial No | Test Item | Calibration Date * Interval(month) |
|--------------------|----------------------------|--------------------------|--|--------------------------------|------------------|---|
| MAEC-01 | Semi Anechoic Chamber(NSA) | TDK | Semi Anechoic Chamber 10m | DA-06881 | CE/RE | 2012/08/01 * 12 |
| MOS-27 | Thermo-Hygrometer | CUSTOM | CTH-201 | A08Q26 | CE/RE | 2012/02/08 * 12 |
| MJM-01 | Measure | KDS | ES19-55 | - | CE/RE | - |
| COTS-MEMI | EMI measurement program | TSJ | TEPTO-DV | - | CE/RE | - |
| MTR-09 | EMI Test Receiver | Rohde & Schwarz | ESU26 | 100412 | CE/RE | 2012/06/14 * 12 |
| MLS-02 | LISN(AMN) | Schwarzbeck | NSLK8127 | 8127383 | CE(AE) | 2012/07/17 * 12 |
| MLS-03 | LISN(AMN) | Schwarzbeck | NSLK8127 | 8127384 | CE(EUT) | 2012/03/01 * 12 |
| MTA-30 | Terminator | TME | CT-01 | - | CE | 2012/01/11 * 12 |
| MCC-03 | Coaxial Cable | Fujikura/Suhner/TSJ | 5D-2W(20m)/ 3D-2W(7.5m)/ RG400u(1.5m)/ RFM-E421(Switcher) | -/01068(Switcher) | CE | 2012/01/22 * 12 |
| MAT-64 | Attenuator(13dB) | JFW Industries, Inc. | 50FP-013H2 N | - | CE | 2012/01/28 * 12 |
| KBA-05 | Biconical Antenna | Schwarzbeck | BBA9106 | 2513 | RE | 2012/11/18 * 12 |
| KLA-04 | Logperiodic Antenna | Schwarzbeck | USLP9143 | 361 | RE | 2012/11/18 * 12 |
| MAT-08 | Attenuator(6dB) | Weinschel Corp | 2 | BK7971 | RE | 2012/11/06 * 12 |
| MCC-02 | Coaxial Cable | Suhner/storm/Agilent/TSJ | - | - | RE | 2012/09/13 * 12 |
| MPA-19 | Pre Amplifier | MITEQ | MLA-10K01-B01-35 | 1237616 | RE | 2012/02/20 * 12 |
| MHA-05 | Horn Antenna 1-18GHz | Schwarzbeck | BBHA9120D | 253 | RE | 2012/06/27 * 12 |
| MCC-142 | Microwave Cable | Junkosha | MWX221 | 1203S213(1m) / 1204S063(5m) | RE | 2012/04/23 * 12 |
| MPA-01 | Pre Amplifier | Agilent | 8449B | 3008A01671 | RE | 2012/02/28 * 12 |

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

CE: Conducted emission

RE: Radiated emission

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